NAME

CUTEST_cshp - CUTEst tool to evaluate the sparsity pattern of the Hessian of the Lagrangian function.

SYNOPSIS

CALL CUTEST_cshp(status, n, nnzh, lh, H_row, H_col)

DESCRIPTION

The CUTEST_cshp subroutine evaluates the sparsity pattern of the Hessian of the Lagrangian function $l(x, y) = f(x) + y^T c(x)$ for the problem, decoded from a SIF file by the script *sifdecoder*, in coordinate format

The problem under consideration is to minimize or maximize an objective function f(x) over all $x \in R^n$ subject to general equations $c_i(x) = 0$, $(i \in 1, ..., m_E)$, general inequalities $c_i^l \le c_i(x) \le c_i^u$. $(i \in m_E + 1, ..., m)$, and simple bounds $x^l \le x \le x^u$. The objective function is group-partially separable and all constraint functions are partially separable.

ARGUMENTS

The arguments of CUTEST_cshp are as follows

status [out] - integer

the outputr status: 0 for a successful call, 1 for an array allocation/deallocation error, 2 for an array bound error, 3 for an evaluation error,

n [in] - integer

the number of variables for the problem,

nnzh [out] - integer

the number of nonzeros in the Hessian matrix,

lh [in] - integer

the actual declared dimensions of H_row and H_col,

H_row [out] - integer

an array which gives the row indices of the nonzeros of the Hessian matrix of the Lagrangian function; only the upper triangular part of the Hessian is stored, and

H_col [out] - integer

an array which gives the column indices of the nonzeros of the Hessian matrix of the Lagrangian function corresponding to the row indices in H_row.

AUTHORS

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SEE ALSO

CUTEst: a Constrained and Unconstrained Testing Environment with safe threads,

N.I.M. Gould, D. Orban and Ph.L. Toint,

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ACM TOMS, 29:4, pp.373-394, 2003.

CUTE: Constrained and Unconstrained Testing Environment,

I. Bongartz, A.R. Conn, N.I.M. Gould and Ph.L. Toint,

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